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| Notice of References Cited | Application/Control No. 10/085,044 | Applicant(s)/Patent Under Reexamination MIYAKOSHI ET AL. | |
| | Examiner Sean Reilly | Art Unit 2153 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------|----------------|
| | A | US-6,125,122 | 09-2000 | Favichia et al. | 370/466 |
| | B | US-2002/0065099 | 05-2002 | BJORND AHL, PER | 455/553 |
| | C | US-6,285,659 | 09-2001 | Feuerstraeter et al. | 370/244 |
| | D | US-6,425,019 | 07-2002 | Tateyama et al. | 710/11 |
| | E | US-6,504,851 | 01-2003 | Abler et al. | 370/466 |
| | F | US-6,425,019 | 07-2002 | Tateyama et al. | 710/11 |
| | G | US-5,586,117 | 12-1996 | Edem et al. | 370/466 |
| | H | US-6,507,734 | 01-2003 | Berger et al. | 455/410 |
| | I | US-6,832,082 | 12-2004 | Ramaswamy et al. | 455/411 |
| | J | US-4,736,404 | 04-1988 | Anglikowski et al. | 455/411 |
| | K | US-2002/0197985 | 12-2002 | Tourrilhes et al. | 455/420 |
| | L | US-2003/0078036 | 04-2003 | Chang et al. | 455/419 |
| | M | US-5,142,528 | 08-1992 | Kobayashi et al. | 370/469 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
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| | P | | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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